

Maximum Ratings

Parameter	Symbol	Value	Unit
Drain Source voltage slope	d <i>v</i> /dt	50	V/ns
V _{DS} = 400 V, <i>I</i> _D = 16 A, <i>T</i> _j = 125 °C			

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Thermal resistance, junction - case	R _{thJC}	-	-	0.78	K/W
Thermal resistance, junction - ambient, leaded	R _{thJA}	-	-	62	
Soldering temperature, wavesoldering	T _{sold}	-	-	260	°C
1.6 mm (0.063 in.) from case for 10s					

Electrical Characteristics, at Tj=25°C unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, <i>I</i> _D =0.25mA	500	-	-	V
Drain-Source avalanche	V _{(BR)DS}	V _{GS} =0V, <i>I</i> _D =16A	-	600	-	
breakdown voltage						
Gate threshold voltage	V _{GS(th)}	I _D =675μA, V _{GS} =V _{DS}	2.1	3	3.9	
Zero gate voltage drain current	I _{DSS}	V _{DS} =500V, V _{GS} =0V,				μA
		<i>T</i> j=25°C,	-	0.1	1	
		<i>T</i> j=150°C	-	-	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10V, <i>I</i> _D =10A,				Ω
		Tj=25°C	-	0.25	0.28	
		<i>T</i> j=150°C	-	0.68	-	
Gate input resistance	R _G	<i>f</i> =1MHz, open Drain	-	1.5	-	



Parameter	Symbol	Conditions	ditions Valu		es	
			min.	typ.	max.	
Transconductance	<i>9</i> fs	V _{DS} ≥2*I _D *R _{DS(on)max} ,	-	14	-	S
		/ _D =10A				
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V,	-	1600	-	pF
Output capacitance	C _{oss}	<i>f</i> =1MHz	-	800	-	
Reverse transfer capacitance	C _{rss}		-	30	-	
Effective output capacitance, ²⁾	C _{o(er)}	V _{GS} =0V,	-	64	-	pF
energy related		V _{DS} =0V to 400V				
Effective output capacitance, 3)	C _{o(tr)}		-	124	-	
time related						
Turn-on delay time	<i>t</i> _{d(on)}	V _{DD} =380V, V _{GS} =0/10V,	-	10	-	ns
Rise time	<i>t</i> r	/ _D =16A, <i>R</i> _G =4.3Ω	-	8	-	
Turn-off delay time	<i>t</i> d(off)		-	50	-]
Fall time	t _f		-	8	-	1

Electrical Characteristics , at $T_i = 25$ °C, unless otherwise specified

Gate Charge Characteristics

Gate to source charge	Q _{gs}	V _{DD} =380V, / _D =16A	-	7	-	nC
Gate to drain charge	Q _{gd}		-	36	-	
Gate charge total	Qg	V _{DD} =380V, / _D =16A, V _{GS} =0 to 10V	-	66	-	
Gate plateau voltage	V _{(plateau}	V _{DD} =380V, / _D =16A	-	5	-	V

⁰J-STD20 and JESD22

¹Repetitve avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR}^* f$.

 ${}^{2}C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} . ${}^{3}C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} . ${}^{4}I_{SD} <= I_{D}$, di/dt<=400A/us, $V_{DClink} = 400V$, $V_{peak} < V_{BR, DSS}$, $T_{j} < T_{j}$,max. Identical low-side and high-side switch.

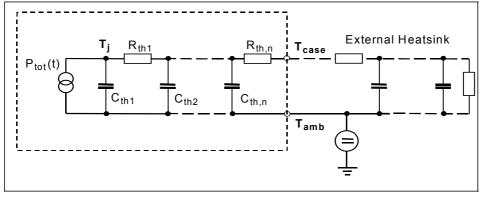


Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.]
Inverse diode continuous	I _S	T _C =25°C	-	-	16	A
forward current						
Inverse diode direct current,	/ _{SM}	-	_	-	48	
pulsed						
Inverse diode forward voltage	V _{SD}	V _{GS} =0V, I _F =I _S	-	1	1.2	V
Reverse recovery time	<i>t</i> _{rr}	V _R =380V, I _F =I _S ,	-	420	-	ns
Reverse recovery charge	Q _{rr}	d <i>i_F/d<i>t</i>=100A/µs</i>	-	7	-	μC
Peak reverse recovery current	<i>I</i> _{rrm}		-	40	-	A
Peak rate of fall of reverse	di _{rr} /dt		-	tbd	-	A/µs
recovery current						

Electrical Characteristics, at $T_i = 25$ °C, unless otherwise specified

Typical Transient Thermal Characteristics

Symbol	Value	Unit	Symbol	Value	Unit
	typ.			typ.	
Thermal r	esistance		Thermal c	capacitance	·
R _{th1}	0.012	K/W	C _{th1}	0.0002495	Ws/K
R _{th2}	0.023		C _{th2}	0.0009406	
R _{th3}	0.043		C _{th3}	0.001298	
R _{th4}	0.149		C _{th4}	0.00362	
R _{th5}	0.17		C _{th5}	0.009484	
R _{th6}	0.069		C _{th6}	0.077	

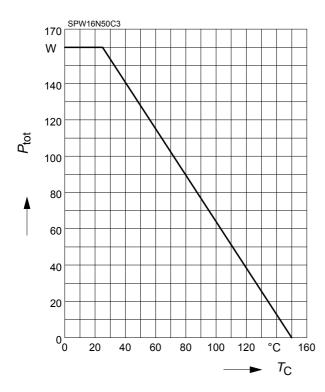


Rev. 2.5Page 42008-02-11Please note the new package dimensions arccording to PCN 2009-134-ADownloaded from Arrow.com



1 Power dissipation

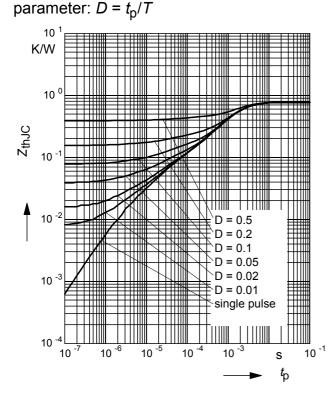
 $P_{\text{tot}} = f(T_{\text{C}})$



3 Transient thermal impedance

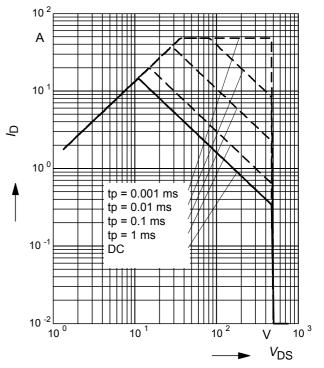
 $Z_{\text{thJC}} = f(t_{\text{p}})$

Rev. 2.5



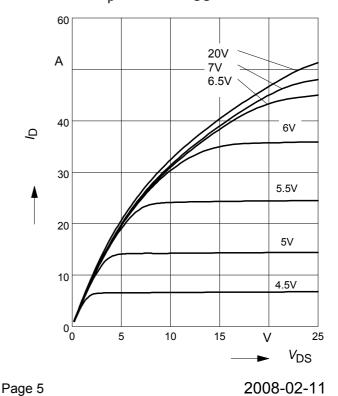
2 Safe operating area

 $I_{\rm D} = f(V_{\rm DS})$ parameter : D = 0, $T_{\rm C}=25^{\circ}{\rm C}$



4 Typ. output characteristic

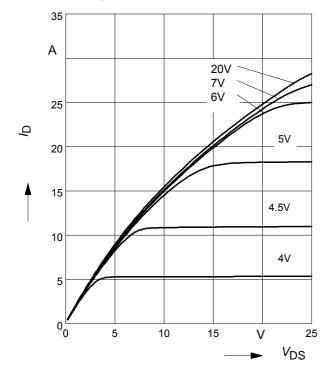
 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j}=25^{\circ}{\rm C}$ parameter: $t_{\rm p} = 10 \ \mu{\rm s}, V_{\rm GS}$





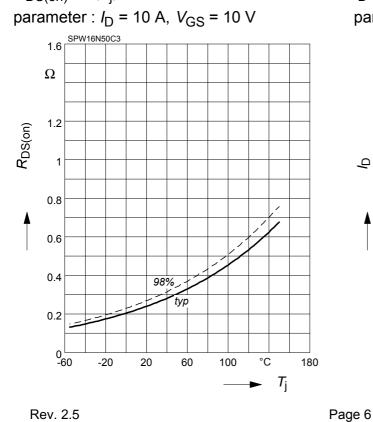
5 Typ. output characteristic

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j}=150^{\circ}{\rm C}$ parameter: $t_{\rm p} = 10 \ \mu{\rm s}, V_{\rm GS}$



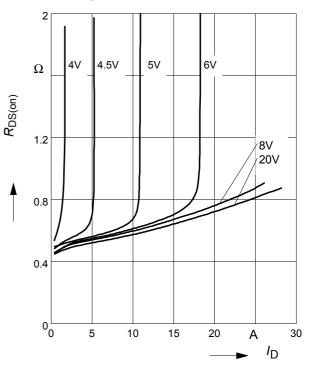
7 Drain-source on-state resistance

 $R_{\text{DS(on)}} = f(T_{j})$



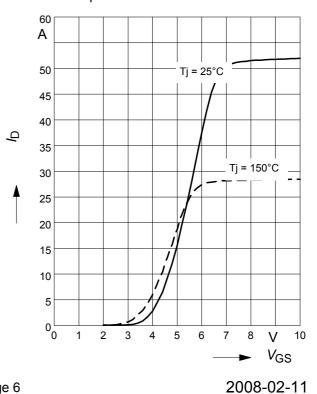
6 Typ. drain-source on resistance

 $R_{\text{DS(on)}}=f(I_{\text{D}})$ parameter: $T_{j}=150^{\circ}\text{C}$, V_{GS}



8 Typ. transfer characteristics

 $I_{\rm D}$ = f ($V_{\rm GS}$); $V_{\rm DS}$ \geq 2 x $I_{\rm D}$ x $R_{\rm DS(on)max}$ parameter: $t_{\rm p}$ = 10 µs



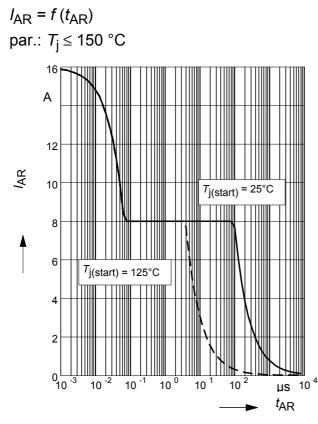


9 Typ. gate charge

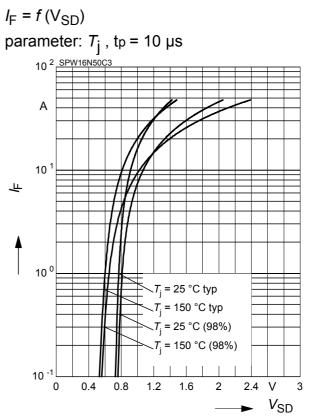
 $V_{\text{GS}} = f \ (Q_{\text{Gate}})$ parameter: I_D = 16 A pulsed SPW16N50C3 V 12 Vgs 0.2 V_{DS max} 10 0.8 V_{DS max} 8 6 4 2 0 0 nC 100 10 20 30 40 50 60 70 80 **Q**Gate

11 Avalanche SOA

Rev. 2.5

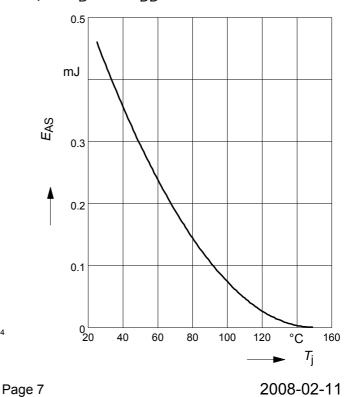


10 Forward characteristics of body diode



12 Avalanche energy

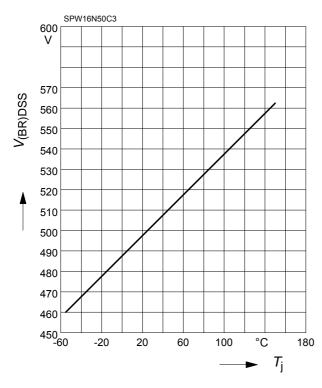
 $E_{AS} = f(T_j)$ par.: $I_D = 8$, $V_{DD} = 50$ V





13 Drain-source breakdown voltage

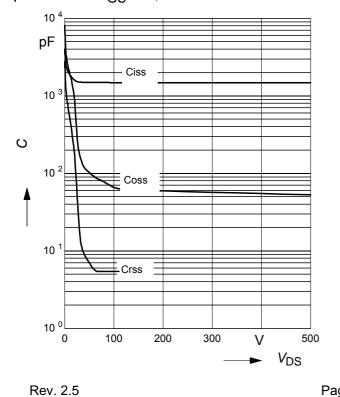
 $V_{(BR)DSS} = f(T_j)$



15 Typ. capacitances

 $C = f(V_{DS})$

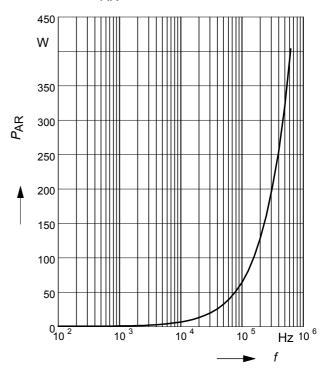
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parameter: V<sub>GS</sub>=0V, f=1 MHz
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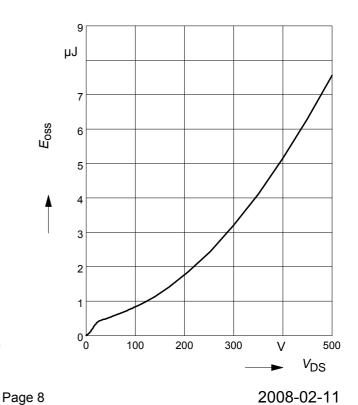
14 Avalanche power losses

 $P_{\mathsf{AR}} = f(f)$

parameter: EAR=0.64mJ

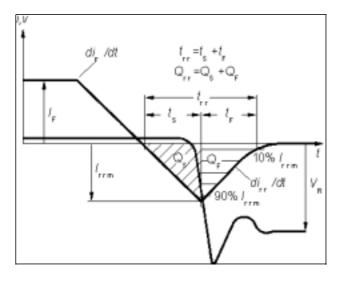


16 Typ. C_{OSS} stored energy $E_{\text{OSS}} = f(V_{\text{DS}})$





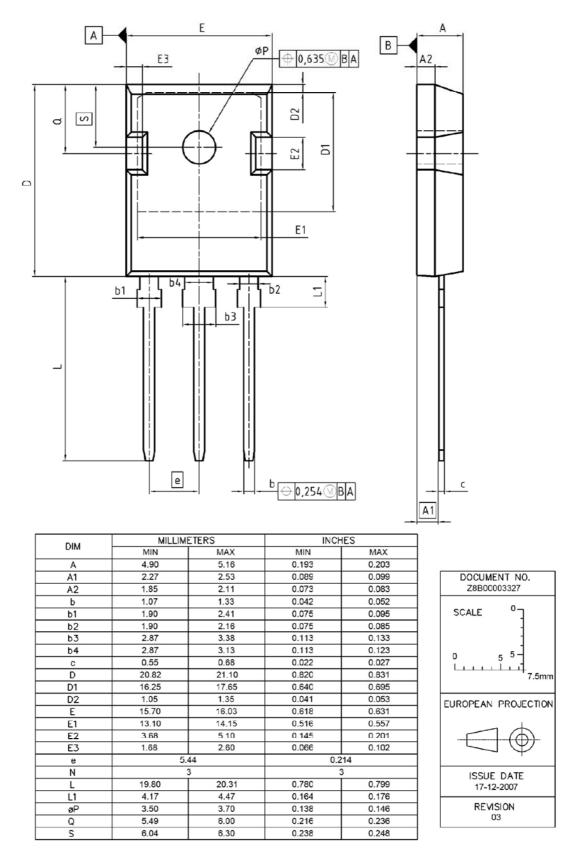
Definition of diodes switching characteristics







PG-TO-247-3-1



Rev. 2.5

Page 10

2008-02-11



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New package outlines TO-247

1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

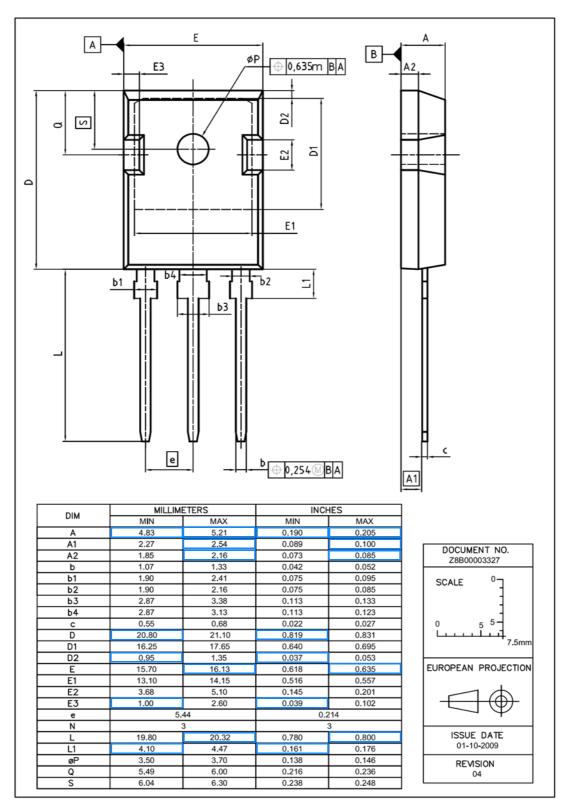


Figure 1 Outlines TO-247, dimensions in mm/inches

Final Data Sheet Erratum